

# Single N-channel MOSFET

## ELM13416CA-S

### ■General description

ELM13416CA-S uses advanced trench technology to provide excellent  $R_{ds(on)}$ , low gate charge and operation with gate voltages as low as 1.8V and internal ESD protection is included.

### ■Features

- $V_{ds}=20V$
- $I_d=6.5A$  ( $V_{gs}=4.5V$ )
- $R_{ds(on)} < 22m\Omega$  ( $V_{gs}=4.5V$ )
- $R_{ds(on)} < 26m\Omega$  ( $V_{gs}=2.5V$ )
- $R_{ds(on)} < 34m\Omega$  ( $V_{gs}=1.8V$ )
- ESD protected

### ■Maximum absolute ratings

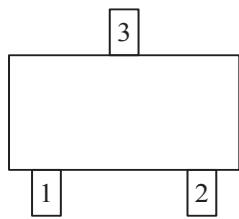
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	$V_{ds}$	20	V	
Gate-source voltage	$V_{gs}$	$\pm 8$	V	
Continuous drain current	$I_d$	6.5	A	
		5.2		
Pulsed drain current	$I_{dm}$	30	A	3
Power dissipation	$P_d$	1.4	W	2
		0.9		
Junction and storage temperature range	$T_j, T_{stg}$	-55 to 150	°C	

### ■Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$t \leq 10s$	$R_{\theta ja}$	70	90	°C/W	1
Maximum junction-to-ambient	Steady-state		100	125	°C/W	1, 4
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	63	80	°C/W	

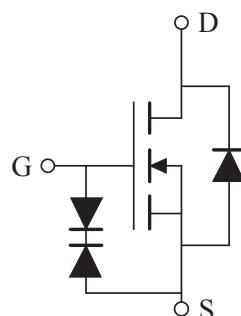
### ■Pin configuration

SOT-23(TOP VIEW)



Pin No.	Pin name
1	GATE
2	SOURCE
3	DRAIN

### ■Circuit



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### ■Electrical characteristics

T<sub>a</sub>=25°C

Parameter	Symbol	Condition		Min.	Typ.	Max.	Unit	
<b>STATIC PARAMETERS</b>								
Drain-source breakdown voltage	BV <sub>dss</sub>	Id=250μA, V <sub>gs</sub> =0V		20			V	
Zero gate voltage drain current	Id <sub>ss</sub>	V <sub>ds</sub> =20V, V <sub>gs</sub> =0V	T <sub>j</sub> =55°C		1		μA	
					5			
Gate-body leakage current	I <sub>gss</sub>	V <sub>ds</sub> =0V, V <sub>gs</sub> =±8V				±10	μA	
Gate threshold voltage	V <sub>gs(th)</sub>	V <sub>ds</sub> =V <sub>gs</sub> , Id=250μA		0.4	0.7	1.1	V	
On state drain current	Id(on)	V <sub>gs</sub> =4.5V, V <sub>ds</sub> =5V		30			A	
Static drain-source on-resistance	R <sub>ds(on)</sub>	V <sub>gs</sub> =4.5V, Id=6.5A			16	22	mΩ	
		T <sub>j</sub> =125°C			22	30		
		V <sub>gs</sub> =2.5V, Id=5.5A			18	26		
		V <sub>gs</sub> =1.8V, Id=5A			21	34		
Forward transconductance	G <sub>fs</sub>	V <sub>ds</sub> =5V, Id=6.5A			50		S	
Diode forward voltage	V <sub>sd</sub>	I <sub>s</sub> =1A, V <sub>gs</sub> =0V			0.62	1.00	V	
Max. body-diode continuous current	I <sub>s</sub>					2	A	
<b>DYNAMIC PARAMETERS</b>								
Input capacitance	C <sub>iss</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =10V, f=1MHz			1295	1650	pF	
Output capacitance	C <sub>oss</sub>				160		pF	
Reverse transfer capacitance	C <sub>rss</sub>				87		pF	
Gate resistance	R <sub>g</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =0V, f=1MHz			1.8		kΩ	
<b>SWITCHING PARAMETERS</b>								
Total gate charge	Q <sub>g</sub>	V <sub>gs</sub> =4.5V, V <sub>ds</sub> =10V, Id=6.5A			10.0		nC	
Gate-source charge	Q <sub>gs</sub>				4.2		nC	
Gate-drain charge	Q <sub>gd</sub>				2.6		nC	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>gs</sub> =4.5V, V <sub>ds</sub> =10V R <sub>l</sub> =1.54Ω, R <sub>gen</sub> =3Ω			280.00		ns	
Turn-on rise time	t <sub>r</sub>				328.00		ns	
Turn-off delay time	t <sub>d(off)</sub>				3.76		ns	
Turn-off fall time	t <sub>f</sub>				2.24		ns	
Body diode reverse recovery time	t <sub>rr</sub>	I <sub>f</sub> =6.5A, dI/dt=100A/μs			31	41	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	I <sub>f</sub> =6.5A, dI/dt=100A/μs			6.8		nC	

#### NOTE :

- The value of R<sub>θja</sub> is measured with the device mounted on 1in2 FR-4 board of 2oz. Copper, in still air environment with T<sub>a</sub>=25°C. The value in any given application depends on the user's specific board design.
- The power dissipation P<sub>d</sub> is based on T<sub>j</sub>(Max)=150°C, using 10s junction-to-ambient thermal resistance.
- Repetitive rating, pulse width limited by junction temperature T<sub>j</sub>(Max)=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>j</sub>=25°C.
- The R<sub>θja</sub> is the sum of the thermal impedance from junction to lead R<sub>θjl</sub> and lead to ambient.
- The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in2 FR-4 board with 2oz.Copper, assuming a maximum junction temperature of T<sub>j</sub>(Max)=150°C. The SOA curve provides a single pulse rating.



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## ■ Typical electrical and thermal characteristics

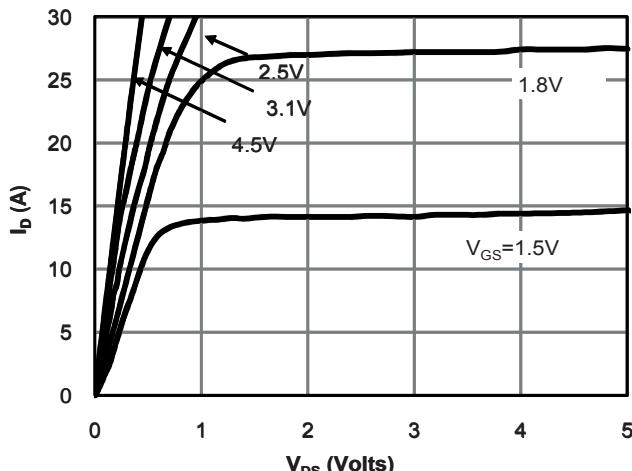


Fig 1: On-Region Characteristics (Note E)

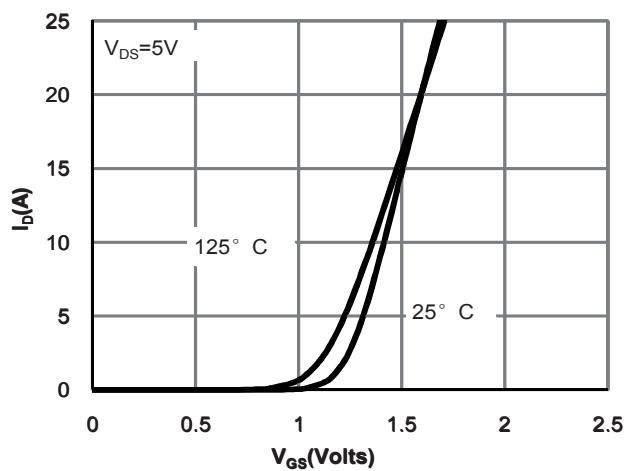


Figure 2: Transfer Characteristics (Note E)

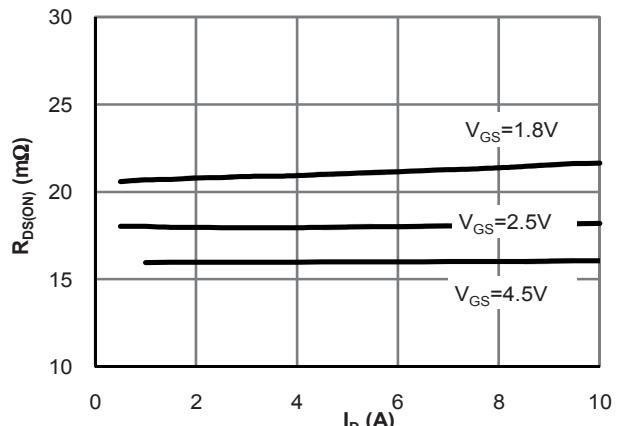


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

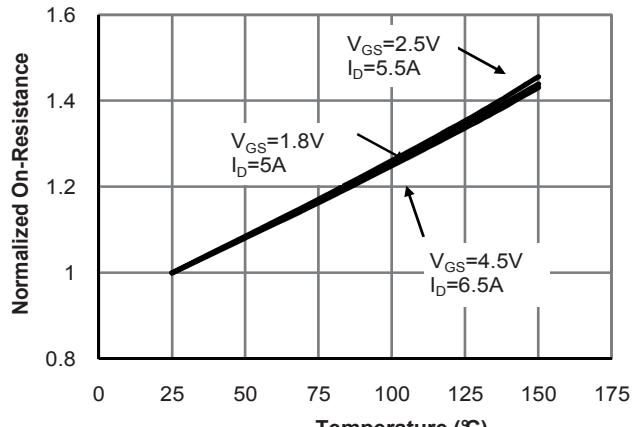


Figure 4: On-Resistance vs. Junction Temperature (Note E)

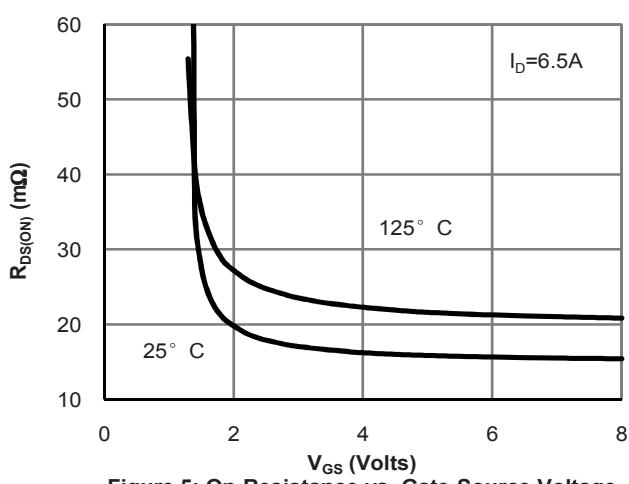


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

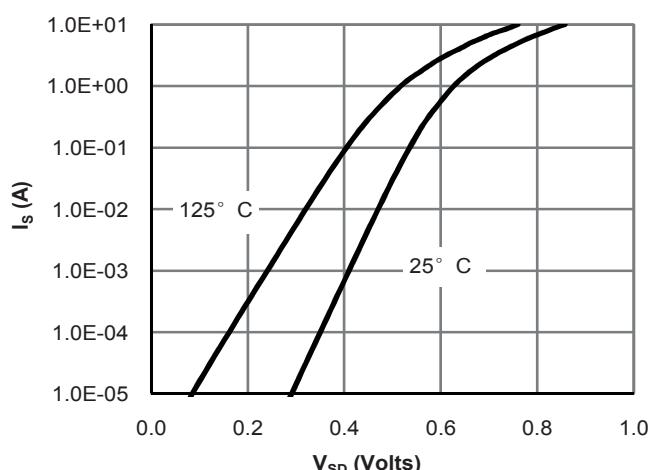


Figure 6: Body-Diode Characteristics (Note E)

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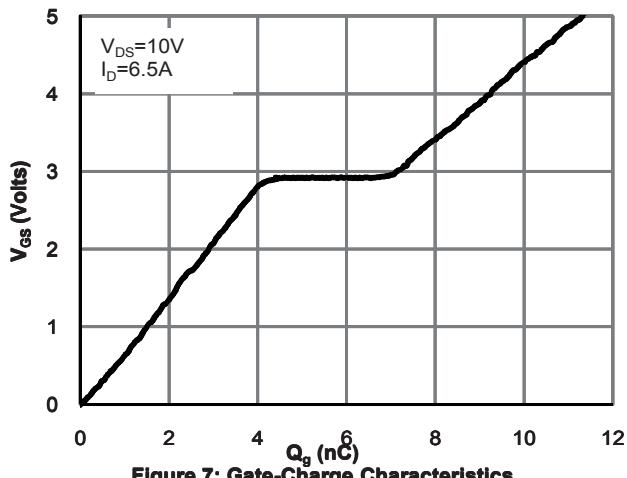


Figure 7: Gate-Charge Characteristics

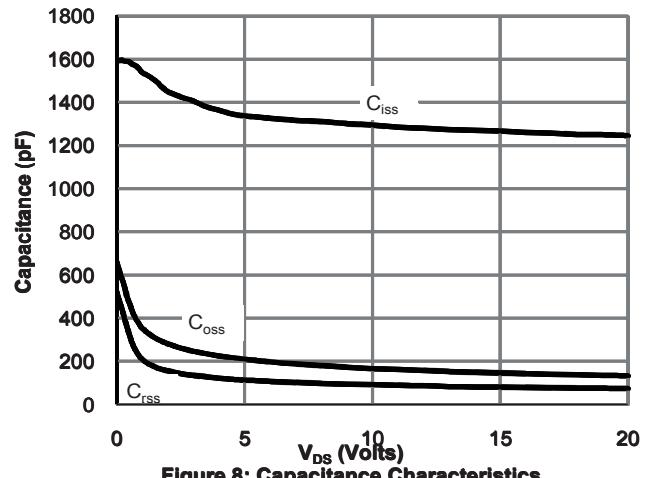


Figure 8: Capacitance Characteristics

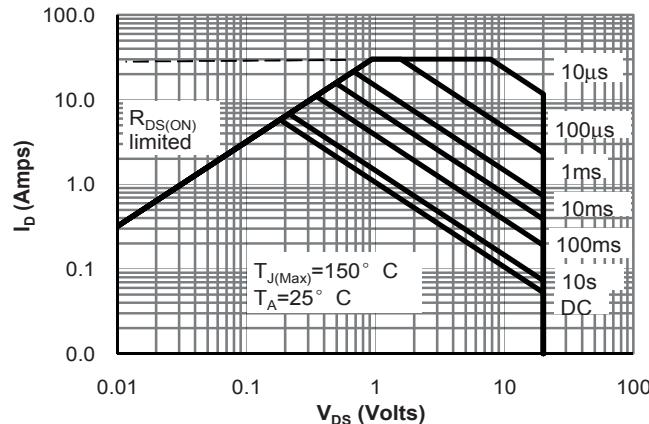


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

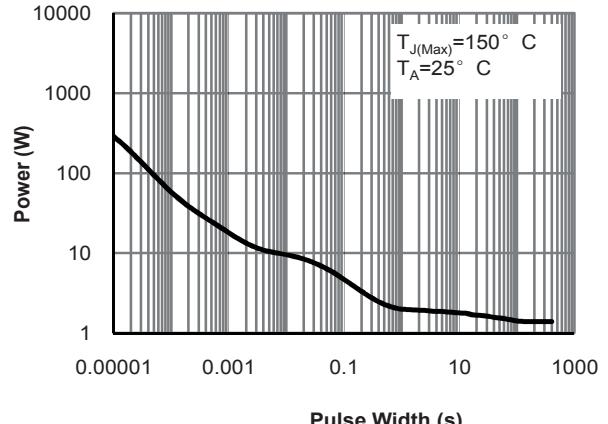


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

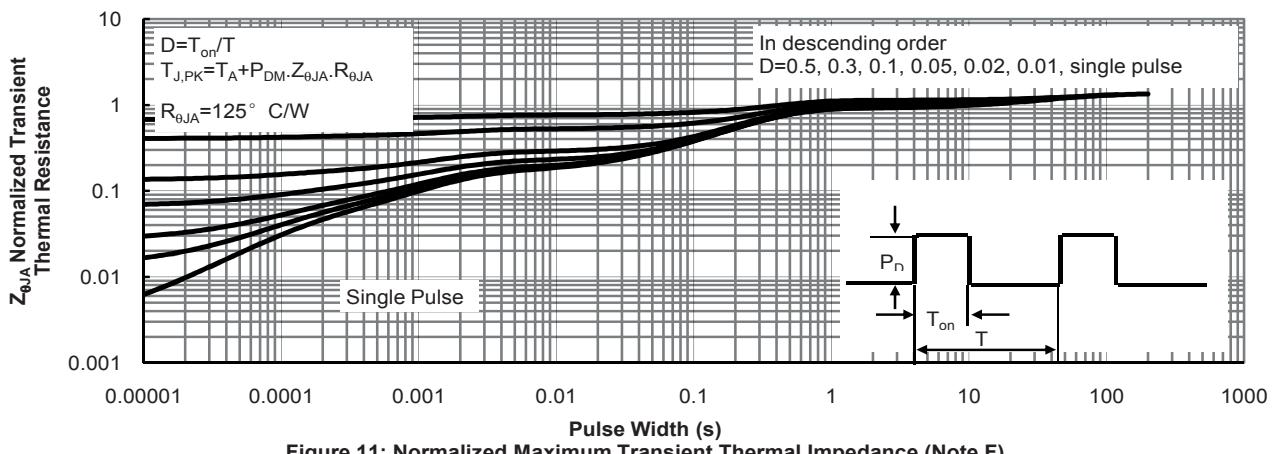


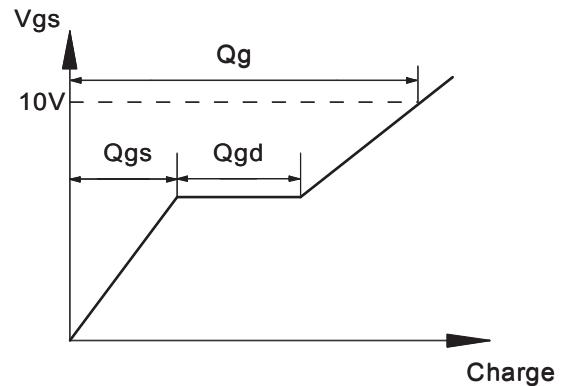
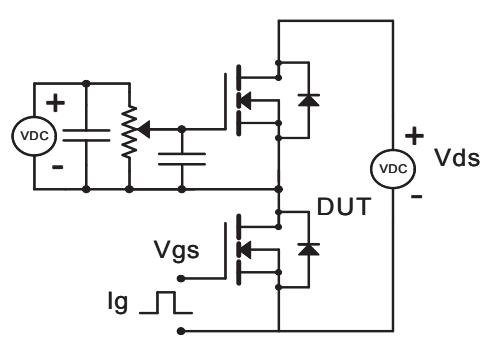
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

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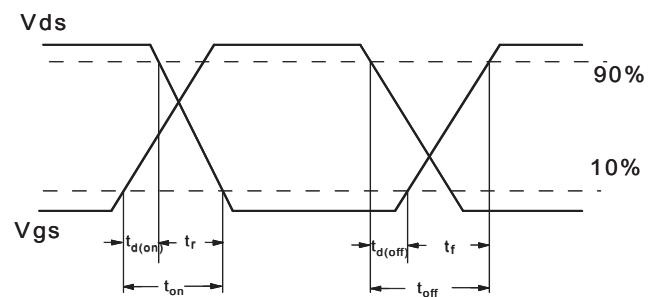
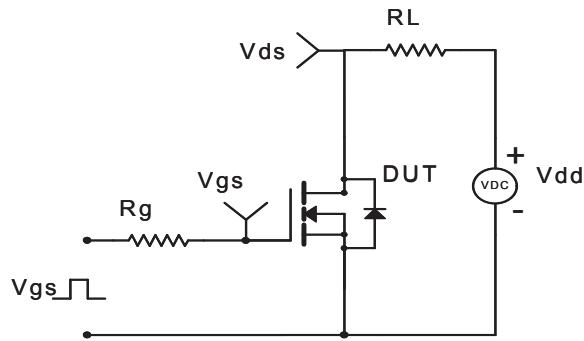
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## ■ Test circuit & waveform

Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

